

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Report No: CCISE190303301

FCC REPORT (GSM & WCDMA)

Applicant: MOVILTELCO TRADE, S.L

Address of Applicant: ABTAO, 25-1Floor A-office MADRID Spain

Equipment Under Test (EUT)

Product Name: mobile phone

Model No.: A87, A87A, A87B, A87C, A87D

Trade mark: mtt

FCC ID: 2ACQKTELCO021

FCC CFR Title 47 Part 2

Applicable standards: FCC CFR Title 47 Part 22 Subpart H

FCC CFR Title 47 Part 24 Subpart E

Date of sample receipt: 12 Mar., 2019

Date of Test: 12 Mar., to 02 Apr., 2019

Date of report issued: 03 Apr., 2019

Test Result: PASS*

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

This report may only be reproduced and distributed in full. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards.

This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 90 days only.





2. Version

Version No.	Date	Description
00	03 Apr., 2019	Original

Tested by: Mike OU Date: 03 Apr., 2019

Test Engineer

Reviewed by: Date: 03 Apr., 2019

Project Engineer



3. Contents

		Page
1. CC	OVER PAGE	1
2. VE	ERSION	2
3. CO	ONTENTS	3
4. TE	EST SUMMARY	4
	ENERAL INFORMATION	
5.1	CLIENT INFORMATION	5
5.2	GENERAL DESCRIPTION OF E.U.T.	
5.3	TEST MODES	
5.4	DESCRIPTION OF SUPPORT UNITS	7
5.5	MEASUREMENT UNCERTAINTY	
5.6	LABORATORY FACILITY	
5.7	LABORATORY LOCATION	
5.8	TEST INSTRUMENTS LIST	8
6. TE	EST RESULTS	9
6.1	CONDUCTED OUTPUT POWER, ERP AND EIRP	9
6.2	PEAK-TO-AVERAGE POWER RATIO	
6.3	OCCUPY BANDWIDTH	14
6.4	MODULATION CHARACTERISTIC	
6.5	OUT OF BAND EMISSION AT ANTENNA TERMINALS	
6.6	FIELD STRENGTH OF SPURIOUS RADIATION MEASUREMENT	
6.7	FREQUENCY STABILITY V.S. TEMPERATURE MEASUREMENT	
6.8	FREQUENCY STABILITY V.S. VOLTAGE MEASUREMENT	35
7 TE	EST SETUP PHOTO	38
8 El	JT CONSTRUCTIONAL DETAILS	40





4. Test Summary

Test Item	Section in CFR 47	Result
RF Exposure (SAR)	Part 1.1307 Part 2.1093	Pass (Please refer to SAR Report)
RF Output Power	Part 2.1046 Part 22.913 (a)(2) Part 24.232 (c)	Pass
Peak-to-Average Power Ratio	Part 24.232 (d)	Pass
Modulation Characteristics	Part 2.1047	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b)	Pass
Out of band emission at antenna terminals	Part 2.1053 Part 22.917 (a) Part 24.238 (a)	Pass
Field strength of spurious radiation	Part 22.917 (a) Part 24.238 (a)	Pass
Frequency stability vs. temperature	Part 22.355 Part 24.235 Part 2.1055(a)(1)(b)	Pass
Frequency stability vs. voltage	Part 22.355 Part 24.235 Part 2.1055(d)(2)	Pass





5. General Information

5.1 Client Information

Applicant:	MOVILTELCO TRADE, S.L
Address:	ABTAO,25-1Floor A-office MADRID Spain
Manufacturer/Factory:	MOVILTELCO TRADE, S.L
Address:	6 floor, building 2, Zhenyan industrial park, No.1 xiangxing road, lanlian; longgang District, Shenzhen, China.

5.2 General Description of E.U.T.

mobile phone
A87, A87A, A87B, A87C, A87D
GSM 850: 824.20MHz-848.80MHz
PCS1900: 1850.20MHz-1909.80MHz
WCDMA Band V: 826.4MHz-846.6MHz
WCDMA Band II: 1852.4 MHz-1907.6 MHz
GSM/GPRS: GMSK, UMTS: QPSK
Internal Antenna
GSM 850: -2.3 dBi
PCS 1900: -3.2 dBi
WCDMA Band V: -2.3 dBi
WCDMA Band II: -3.2 dBi
Rechargeable Li-ion Battery DC3.8V-2000mAh
US and Europe have the same adapter specifications
Model: A87
Input: AC100-240V, 50/60Hz, 0.2A
Output: DC 5.0V, 1A
The test samples were provided in good working order with no visible defects.
item No.: A87, A87A, A87B, A87C, A87D were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being model name.





Operation Frequency List:

GSM 850		PCS1900		
Channel	Frequency (MHz)	Channel	Frequency (MHz)	
128	824.20	512	1850.20	
129	824.40	513	1850.40	
189	836.40	660	1879.80	
190	836.60	661	1880.00	
191	836.80	662	1880.20	
250	848.60	809	1909.60	
251	848.80	810	1909.80	
WC	DMA Band V	WCDMA Band II		
Channel	Frequency (MHz)	Channel	Frequency (MHz)	
4132	826.40	9262	1852.40	
4133	4133 826.60		1852.60	
4182	4182 836.40		1879.80	
4183	836.60	9400	1880.00	
4184	4184 836.80		1880.20	
4232	846.40	9537	1907.40	
4233	846.60	9538	1907.60	

Regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

	GSM850		PCS1900				
Char	nnel	Frequency(MHz)	Channel		Frequency(MHz)		
Lowest	128	824.20	Lowest	512	1850.20		
Middle	190	836.60	Middle	661	1880.00		
Highest	251	848.80	Highest	810	1909.80		
	WCDMA Band V			WCDMA Band II			
Char	Channel		Channel		Frequency(MHz)		
Lowest	4132	826.40	Lowest	9262	1852.40		
Middle	4183	836.60	Middle	9400	1880.00		
Highest	4233	846.60	Highest	9538	1907.60		



5.3 Test modes

Operating Environmen	Operating Environment:		
Temperature:	Normal: 15°C ~ 35°C, Extreme: -30°C ~ +50°C		
Humidity:	20 % ~ 75 % RH		
Atmospheric Pressure:	1008 mbar		
Voltage:	Nominal: 3.8Vdc, Extreme: Low 3.5 Vdc, High 4.35 Vdc		
Test mode:			
GSM mode	Keep the EUT communication with simulated station in GSM mode		
GPRS mode	Keep the EUT communication with simulated station in GPRS mode		
RMC mode	Keep the EUT communication with simulated station in RMC mode		
HSDPA	Keep the EUT communication with simulated station in HSDPA mode		
HSUPA	Keep the EUT communication with simulated station in HSUPA mode		
D 1 T1 F11T1 1			

Remark: The EUT has been tested under continuous transmitting mode. Channel Low, Mid and High for each type band with rated data rate were chosen for full testing. The field strength of spurious radiation emission was measured as EUT stand-up position (H mode) and lie down position (E1, E2 mode) for these modes with power adaptor, earphone and Data cable. Just the worst case position (H mode) shown in report.

5.4 Description of Support Units

Test Equipment	Manufacturer	Model No.	Serial No.	
Simulated Station	Anritsu	MT8820C	6201026545	

5.5 Measurement Uncertainty

Parameters	Expanded Uncertainty
Radiated Emission (9kHz ~ 30MHz)	±2.76 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	±4.28 dB (k=2)
Radiated Emission (1GHz ~ 18GHz)	±5.72 dB (k=2)
Radiated Emission (18GHz ~ 40GHz)	±2.88 dB (k=2)

5.6 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Registration No.: 727551

Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been accredited as a testing laboratory by FCC (Federal Communications Commission). The Registration No. is 727551.

• IC - Registration No.: 10106A-1

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

CNAS - Registration No.: CNAS L6048

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

A2LA - Registration No.: 4346.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: https://portal.a2la.org/scopepdf/4346-01.pdf

Shenzhen Zhongjian Nanfang Testing Co., Ltd.
No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,
Bao'an District, Shenzhen, Guangdong, China
Telephone: +86 (0) 755 23118282 Fax: +86 (0) 755 23116366



5.7 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Address: No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,

Bao'an District, Shenzhen, Guangdong, China Tel: +86-755-23118282, Fax: +86-755-23116366

Email: info@ccis-cb.com, Website: http://www.ccis-cb.com

5.8 Test Instruments list

Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	SAEMC	9m*6m*6m	966	07-22-2017	07-21-2020
DiCanil og Antonna	SCHWARZBECK	VULB9163	497	03-16-2019	03-15-2020
BiConiLog Antenna	SCHWARZBECK	VULD9103	497	03-16-2019	03-15-2020
Biconical Antenna	SCHWARZBECK	VUBA9117	359	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA9120D	916	03-16-2018	03-15-2019
TIOTH Afficentia	SCHWARZBECK	DDI 1A9 120D	910	03-16-2019	03-15-2020
Horn Antenna	SCHWARZBECK	BBHA9120D	1805	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170582	11-21-2018	11-20-2019
EMI Test Software	AUDIX	E3	\	ersion: 6.110919b)
Pre-amplifier	HP	8447D	2944A09358	03-07-2019	03-06-2020
Pre-amplifier	CD	PAP-1G18	11804	03-07-2019	03-06-2020
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	03-07-2019	03-06-2020
Spectrum analyzer	Rohde & Schwarz	FSP40	100363	11-21-2018	11-20-2019
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	03-07-2019	03-06-2020
Spectrum Analyzer	Agilent	N9020A	MY50510123	11-10-2018	11-09-2019
Signal Generator	Rohde & Schwarz	SMX	835454/016	03-07-2019	03-06-2020
Signal Generator	R&S	SMR20	1008100050	03-07-2019	03-06-2020
RF Switch Unit	MWRFTEST	MW200	N/A	N/A	N/A
Test Software	MWRFTEST	MTS8200		Version: 2.0.0.0	
Cable	ZDECL	Z108-NJ-NJ-81	1608458	03-07-2019	03-06-2020
Cable	MICRO-COAX	MFR64639	K10742-5	03-07-2019	03-06-2020
Cable	SUHNER	SUCOFLEX100	58193/4PE	03-07-2019	03-06-2020
DC Power Supply	XinNuoEr	WYK-10020K	1409050110020	10-31-2018	10-30-2019
Temperature Humidity Chamber	HengPu	HPGDS-500	20140828008	09-24-2018	09-23-2019
Simulated Station	Rohde & Schwarz	CMW500	140493	07-16-2018	07-15-2019



6. Test results

6.1 Conducted Output Power, ERP and EIRP

Test Requirement:	FCC part 22.913(a)(2), FCC part 24.232(c)		
Test Method:	ANSI/TIA-603-D 2010		
Limit:	GSM 850: 7W, PCS 1900: 2W WCDMA Band V: 7W, WCDMA Band II: 2W		
Test setup:	System simulator ATT EUT		
Test Procedure:	The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the simulated station. Transmitter output power was read off in dBm.		
Test Instruments:	Refer to section 5.8 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Passed		





Measurement Data:

	Burst Average power (dBm)		
EUT Mode	128	190	251
	824.20 (MHz)	836.60 (MHz)	848.80 (MHz)
GSM 850	31.27	31.17	31.36
GPRS 850 (1 Uplink slot)	31.24	31.26	31.32
GPRS 850 (2 Uplink slot)	29.20	29.12	28.99
GPRS 850 (3 Uplink slot)	27.56	27.46	27.40
GPRS 850 (4 Uplink slot)	26.01	25.91	25.80
Antenna Gain (dBi)	-2.3		
Max. ERP (dBm)	26.91		
ERP Limit (dBm)	38.45		

	Ві	Burst Average power (dBm)		
EUT Mode	512	661	810	
	1850.20 (MHz)	1880.00 (MHz)	1909.80 (MHz)	
PCS 1900	29.46	28.98	29.13	
GPRS 1900 (1 Uplink slot)	29.38	28.91	29.07	
GPRS 1900 (2 Uplink slot)	27.23	26.83	26.65	
GPRS 1900 (3 Uplink slot)	26.01	25.64	25.37	
GPRS 1900 (4 Uplink slot)	24.40	23.95	23.62	
Antenna Gain (dBi)		-3.2		
Max. EIRP (dBm)	26.26			
EIRP Limit (dBm)		33.00		

Note: EIRP(dBm) = Burst Average power(dBm) + Antenna Gain(dBi). ERP(dBm) = EIRP(dBm) - 2.15(dB).



		Bur	rst Average power (dE	3m)
EUT Mode		4132	4183	4233
		826.40 (MHz)	836.60 (MHz)	846.60 (MHz)
	Subtest 1	21.97	19.64	21.35
UMTS 850	Subtest 2	21.59	19.38	21.32
HSDPA	Subtest 3	21.31	18.98	20.87
	Subtest 4	20.82	18.70	20.65
	Subtest 1	21.85	19.61	21.59
LIMTO OFO	Subtest 2	21.87	19.66	21.46
UMTS 850	Subtest 3	21.28	19.12	20.86
HSUPA	Subtest 4	21.77	19.54	21.43
	Subtest 5	21.43	19.12	21.12
UMTS 850 RMC	12.2kbps	22.21	22.25	21.88
UMTS 850 AMR	12.2kbps	22.05	22.10	21.90
Antenna Gain (dBi)		-2.3		
Max. ERP (dBm)		17.65		
ERP Limit (dBm)			38.45	

		Bur	st Average power (dE	3m)
ELIT Mada		9262	9400	9538
EUT Mode	EUT Mode		1880.00	1907.60
		(MHz)	(MHz)	(MHz)
	Subtest 1	21.03	21.58	21.51
UMTS 1900	Subtest 2	20.76	21.17	21.00
HSDPA	Subtest 3	20.42	20.58	20.39
	Subtest 4	20.20	20.22	20.19
	Subtest 1	20.93	21.27	21.09
LIMTC 4000	Subtest 2	20.80	21.35	21.36
UMTS 1900 HSUPA	Subtest 3	20.45	20.53	20.46
поста	Subtest 4	20.82	21.34	21.23
	Subtest 5	20.45	20.95	20.77
UMTS 1900 RMC	12.2kbps	22.82	22.66	22.32
UMTS 1900 AMR	12.2kbps	22.77	22.59	22.24
Antenna Gain (dBi)		-3.2		
Max. EIRP (dBm)		19.62		
EIRP Limit (dBm)			33.00	·

Note: EIRP(dBm) = Burst Average power(dBm) + Antenna Gain(dBi). ERP(dBm) = EIRP(dBm) - 2.15(dB).



6.2 Peak-to-Average Power Ratio

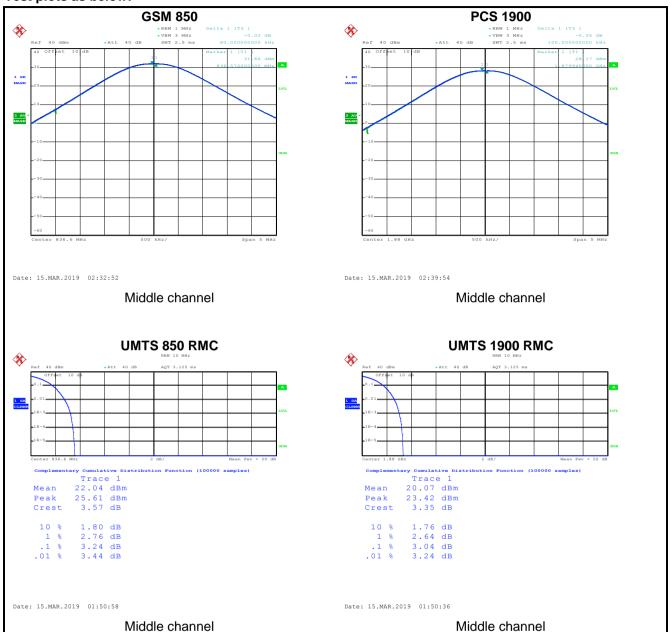
Test Requirement:	FCC part 24.232(d)
Test Method	ANSI/TIA-603-D 2010
Limit:	The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.
Test setup:	
	System simulator Splitter ATT EUT
	Spectrum Analyzer
Test Procedure:	 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. Set the CCDF option in spectrum analyzer, RBW ≥ OBW, Set the EUT working in highest power level, measured and recorded the 0.1% as PAPR level. Repeat step 1~3 at other frequency and modulations.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

Measurement Data:

Modulation	Test channel	PAPR
GSM 850	190	-0.02
PCS 1900	661	-0.05
UMTS 850 RMC	4183	3.24
UMTS 1900 RMC	9400	3.04



Test plots as below:





6.3 Occupy Bandwidth

Test Requirement:	FCC part 22.917(b), FCC part 24.238(b)
Test Method:	ANSI/TIA-603-D 2010
Test setup:	System simulator Splitter ATT EUT Spectrum Analyzer
Test Procedure:	 The EUT's output RF connector was connected with a short cable to the spectrum analyzer RBW was set to about 1% of emission BW, VBW= 3 times RBW. -26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data:

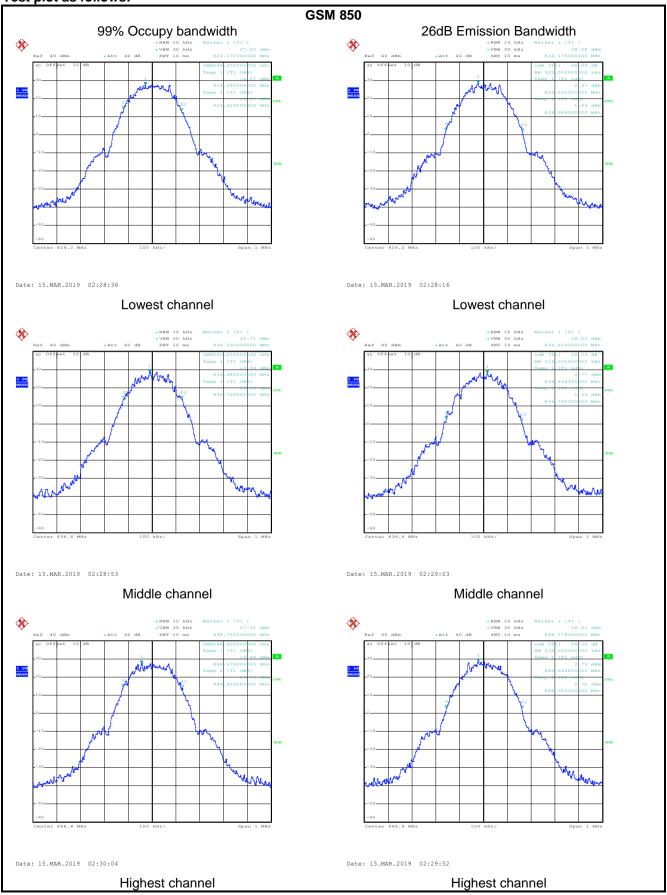
EUT Mode	Channel	Frequency (MHz)	99% Occupy bandwidth (kHz)	-26dB bandwidth (kHz)
	128	824.2	244	322
GSM 850	190	836.6	242	316
	251	848.8	248	318
	512	1850.2	244	322
PCS 1900	661	1880.0	248	314
	810	1909.8	252	322
LIMTO 050	4132	826.4	4160	4680
UMTS 850 12.2k RMC	4183	836.6	4160	4680
12.2K KIVIC	4233	846.6	4140	4640
LIMITO 4000	9262	1852.4	4160	4700
UMTS 1900 12.2k RMC	9400	1880.0	4160	4680
IZ.ZK KIVIC	9538	1907.6	4160	4700

Note:

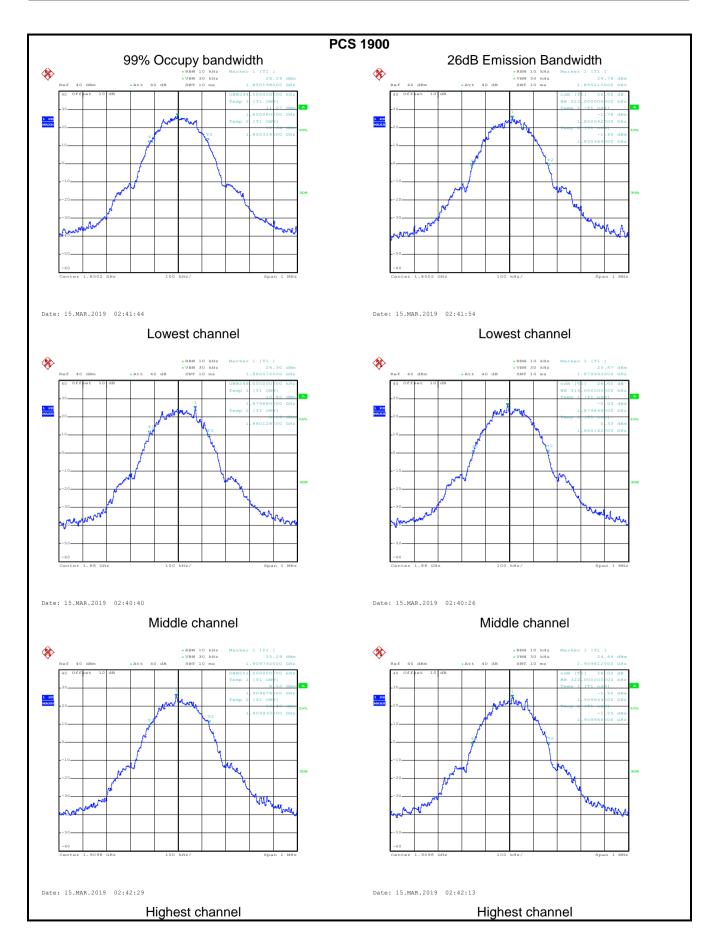
GSM & GPRS use the same modulation technical (GMSK), and with the same channels, so the 99% OBW and the -26dB of GPRS not performed.



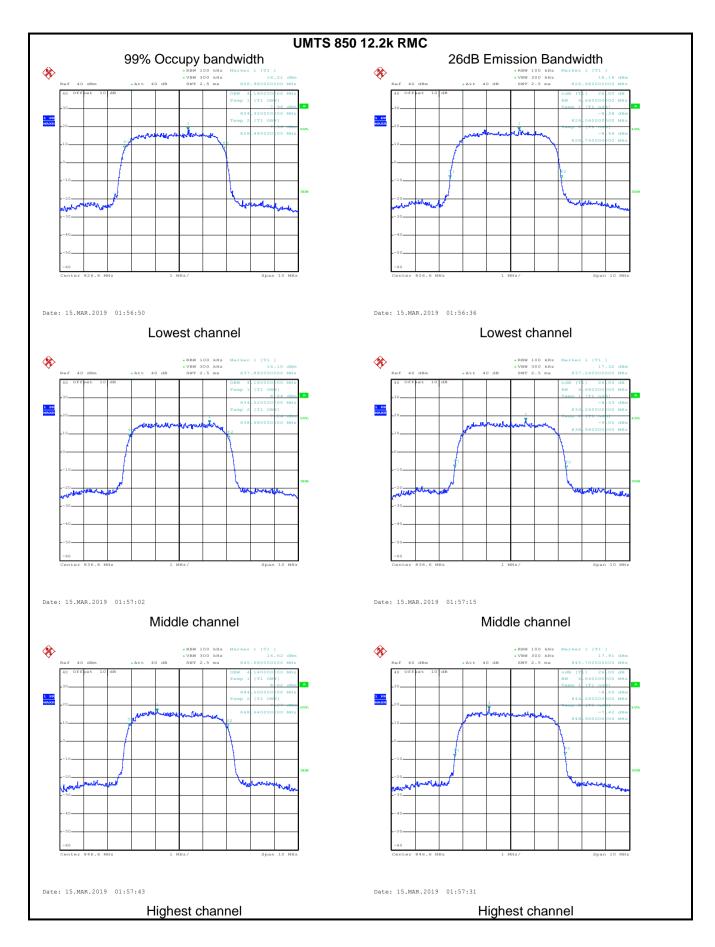
Test plot as follows:



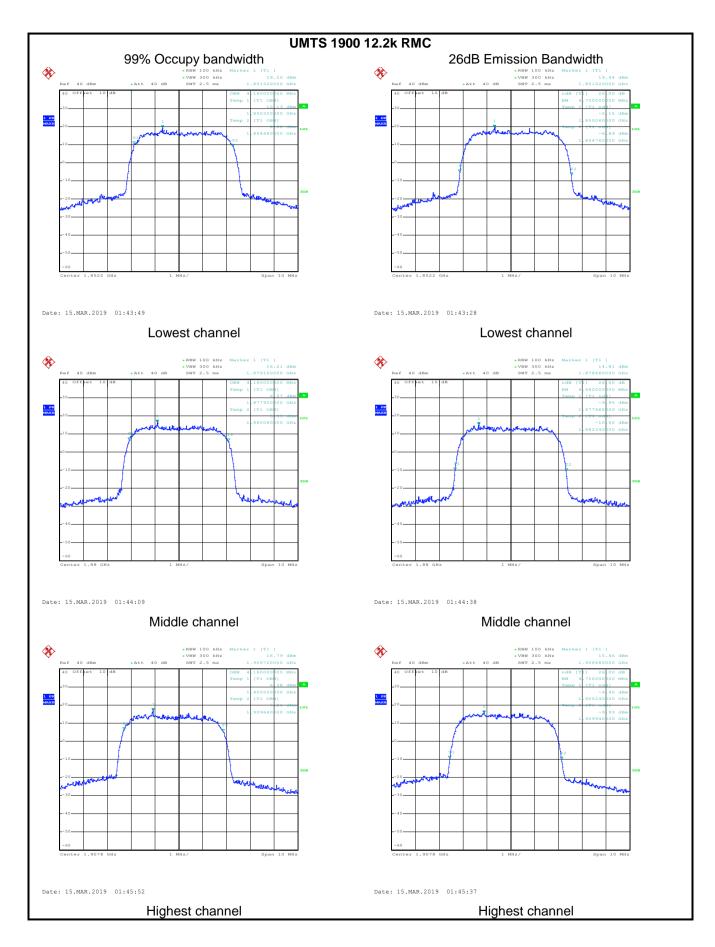














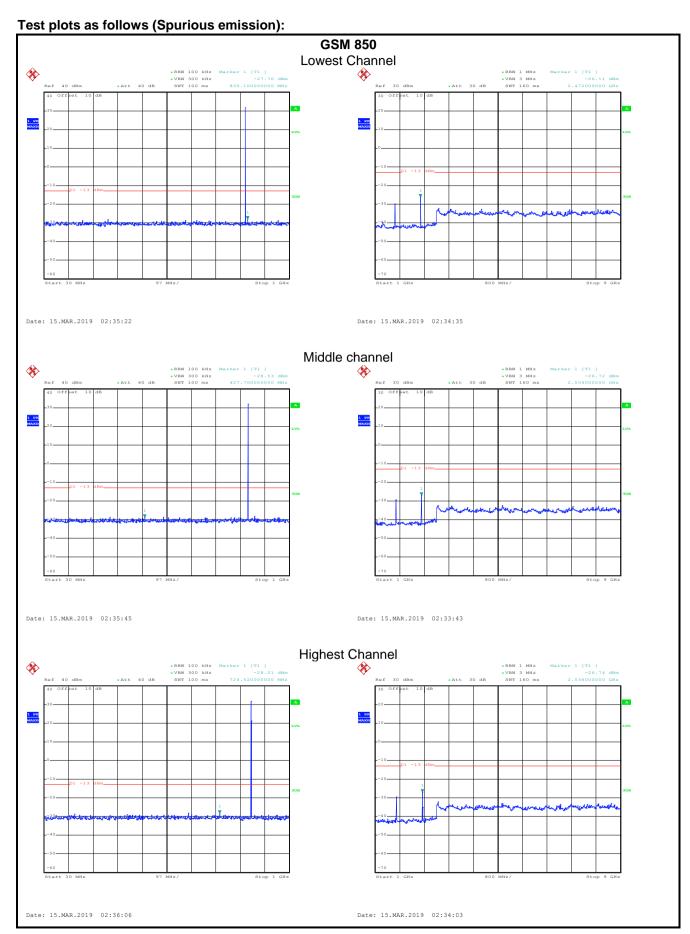
6.4 Modulation Characteristic

According to FCC § 2.1047(d), Part 22H & 24E there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.

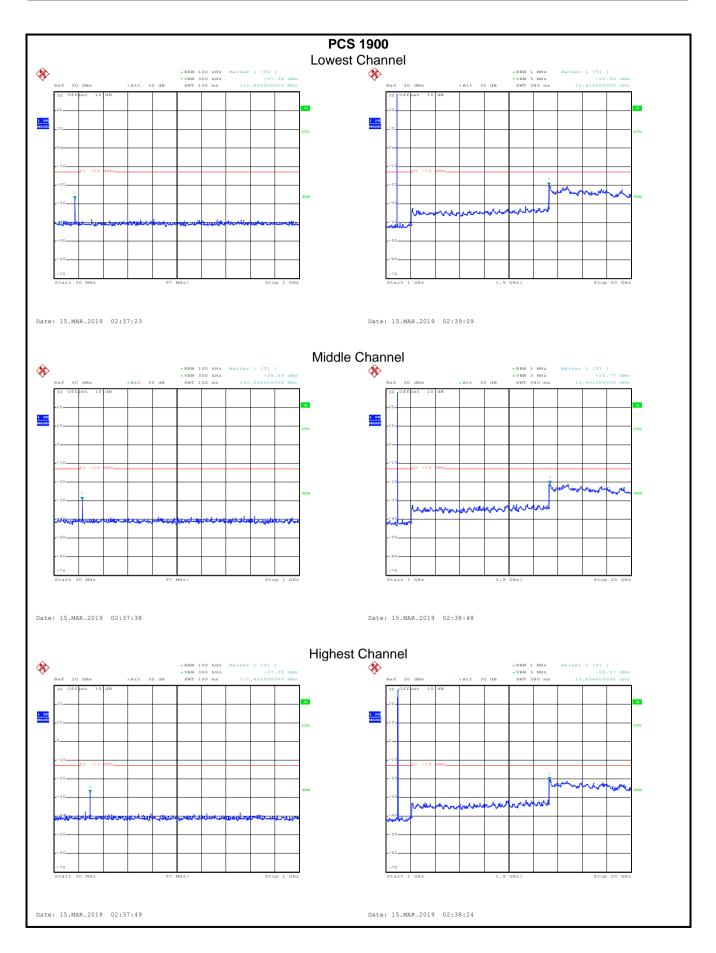
6.5 Out of band emission at antenna terminals

Test Requirement:	FCC part 22.917(a), FCC part 24.238(a)
Test Method:	ANSI/TIA-603-D 2010
Limit:	-13dBm
Test setup:	System simulator Spectrum Analyzer
Test Procedure:	 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. The resolution bandwidth of the spectrum analyzer was set at 100 kHz when below 1GHz, 1MHz when above 1 GHz; sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic. For the out of band: Set the RBW=100 kHz, VBW=300 kHz when below 1 GHz, RBW =1 MHz, VBW=3 MHz when above 1 GHz, Start=30MHz, Stop= 10th harmonic. Band Edge Requirements: In the 1 MHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of at least 1 percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

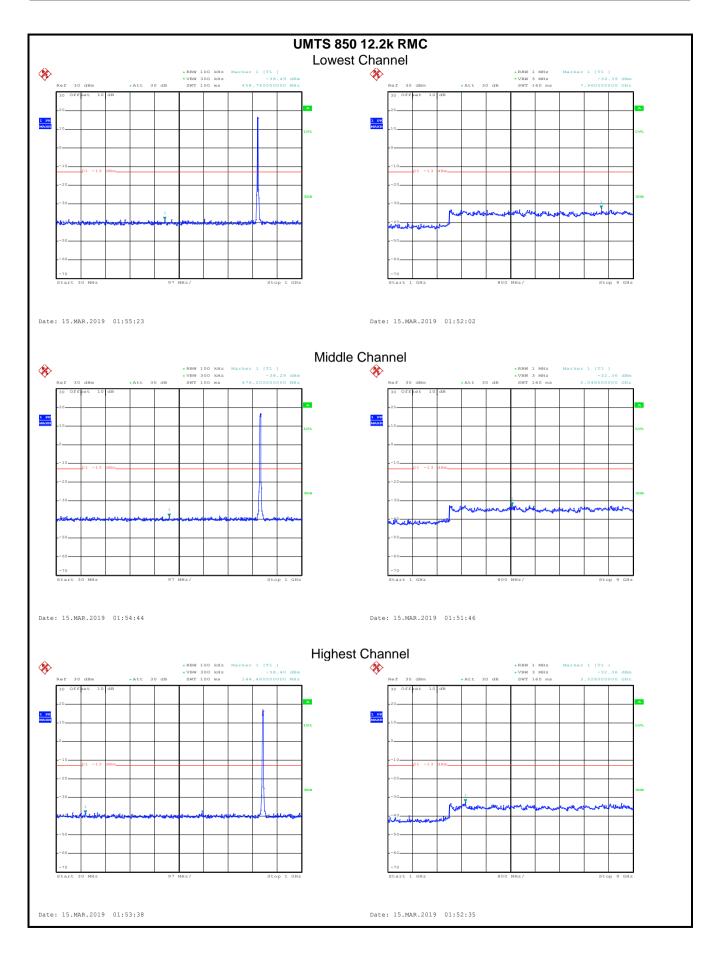




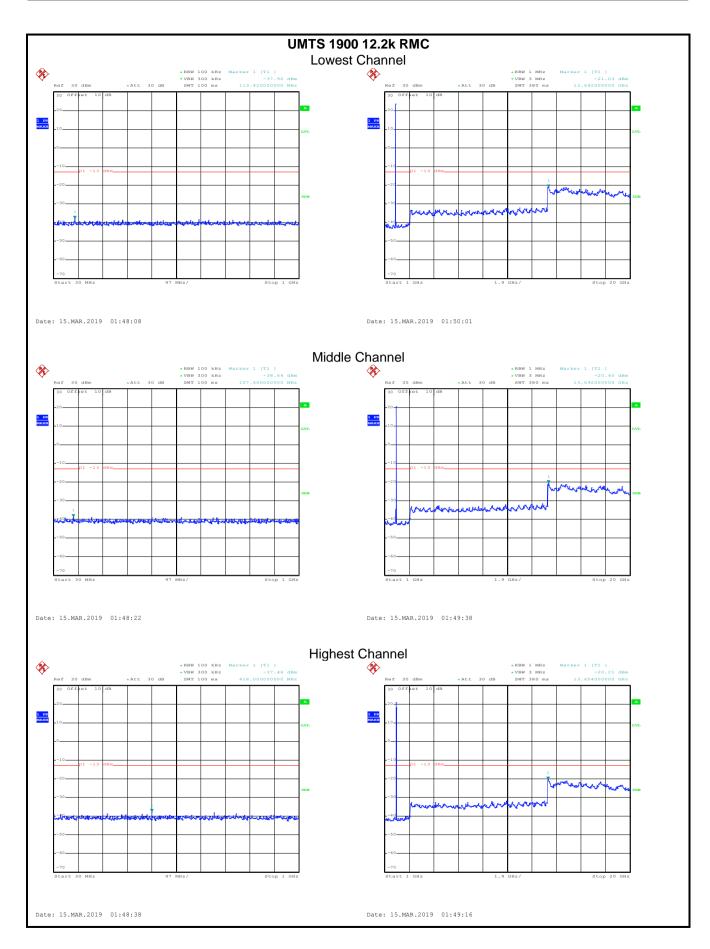






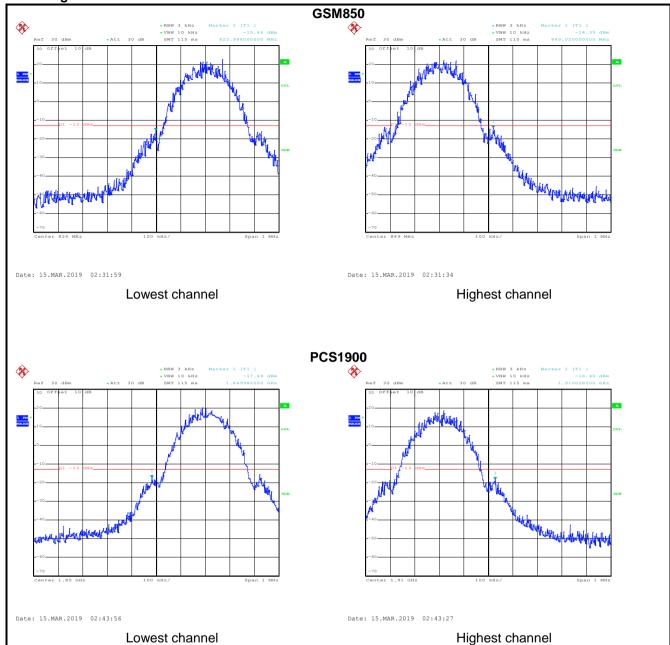




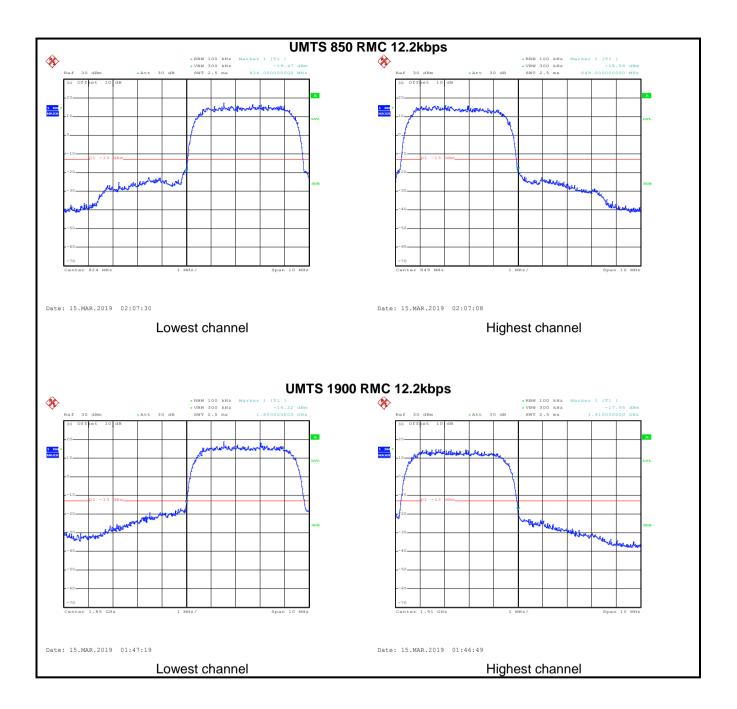














6.6 Field strength of spurious radiation measurement

Test Requirement:	FCC part 22.917(a), FCC part 24.238(a)
Test Method:	ANSI/TIA-603-D 2010
Limit:	-13dBm
Test setup:	Below 1GHz
	Antenna Tower Antenna Tower Ground Reference Plane Test Receive Test Receive Test Receive Test Receive
	Above 1GHz
	Antenna Tower Ground Reference Plane Test Receiver Test Receiver Test Receiver Test Receiver
Test Procedure:	 The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details.
Test results:	Passed





Measurement Data (worst case):

		GSM850		
		Lowest channel		
[Spurious	Spurious Emission		- ·
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1648.40	Vertical	-40.65		Pass
2472.60	V	-41.19	-13.00	
3296.80	V	-40.05		
1648.40	Horizontal	-39.13		
2472.60	Н	-43.59	-13.00	Pass
3296.80	Н	-41.67		
		Middle channel		
Fraguenov (MHz)	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1673.20	Vertical	-41.88		Pass
2509.80	V	-43.39	-13.00	
3346.40	V	-37.72		
1673.20	Horizontal	-45.63		
2509.80	Н	-44.49	-13.00	Pass
3346.40	Н	-38.69		
		Highest channel		
[Spurious	Emission	Limpit (alDum)	Daguit
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1697.60	Vertical	-42.38		
2546.40	V	-40.49	-13.00	Pass
3395.20	V	-39.59		
1697.60	Horizontal	-46.92		
2546.40	Н	-43.75	-13.00	Pass
3395.20	Н	-41.62		

Remark:

The emission levels of below 1 GHz are very lower than the limit and not show in test report.





		PCS1900		
		Lowest channel		
Fragues av (MUz)	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	
3700.40	Vertical	-32.48	-13.00	Pass
5550.60	V	-41.56	-13.00	Pass
3700.40	Horizontal	-33.82	-13.00	Doos
5550.60	Н	-42.49	-13.00	Pass
		Middle channel		
Гла ж а ж (МП I=)	Spurious	Emission	Limit (dDas)	Danult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3760.00	Vertical	-32.18	40.00	Pass
5640.00	V	-43.53	-13.00	
3760.00	Horizontal	-32.31	42.00	David
5640.00	Н	-42.85	-13.00	Pass
·		Highest channel		
	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	
3819.60	Vertical	-32.91	42.00	Dese
5729.40	V	-40.24	-13.00	Pass
3819.60	Horizontal	-31.72	12.00	Door
5729.40	Н	-41.58	-13.00	Pass

Remark:

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.





	WCD	MA BAND V 12.2k RN	AC		
		Lowest channel			
(\All_{-})	Spurious	Emission	1: :: (15.)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)		
1652.80	Vertical	-48.34		Pass	
2479.20	V	-52.51	-13.00		
3305.60	V	-47.14			
1652.80	Horizontal	-53.14			
2479.20	Н	-54.41	-13.00	Pass	
3305.60	Н	-48.59			
		Middle channel			
F (A411.)	Spurious	Emission	L'arit (IDar)	Desuit	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
1673.20	Vertical	-50.89		Pass	
2509.80	V	-51.1	-13.00		
3346.40	V	-49.92			
1673.20	Horizontal	-53.37		Pass	
2509.80	Н	-52.07	-13.00		
3346.40	Н	-49.37			
		Highest channel			
F (NALL-)	Spurious Emission		Line it (dDun)	D It	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
1693.20	Vertical	-50.95		Pass	
2539.80	V	-53.77	-13.00		
3386.40	V	-49.7	1		
1693.20	Horizontal	-51.96			
2539.80	Н	-54.54	-13.00	Pass	
3386.40	Н	-49.13	1		

The emission levels of below 1 GHz are very lower than the limit and not show in test report.



	WCE	MA Band II 12.2k RM	IC				
		Lowest channel					
Fraguency (MUz)	Spurious Emission		Limit (dPm)	Desuit			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
3704.80	Vertical	-32.6	-13.00	Door			
5557.20	V	-44.57	-13.00	Pass			
3704.80	Horizontal	-34.95	42.00	D			
5557.20	Н	-41.6	-13.00	Pass			
Middle channel							
[Spurious Emission		Limit (ADas)	D II			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
3760.00	Vertical	-40.44	40.00	Dana			
5640.00	V	-44.05	-13.00	Pass			
3760.00	Horizontal	-38.74	40.00	Pass			
5640.00	Н	-44.46	-13.00				
		Highest channel	<u>. </u>				
[Spurious Emission		Livit (ID)				
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
3815.20	Vertical	-37.19	42.00	Pass			
5722.80	V	-43.48	-13.00				
3815.20	Horizontal	-37.46	42.00	Davis			
5722.80	Н	-43.48	-13.00	Pass			

Remark:

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.



6.7 Frequency stability V.S. Temperature measurement

Toot Dominos out	FOO D-# 00 0FF FOO D-# 04 00F
Test Requirement:	FCC Part 22.355, FCC Part 24.235
	FCC Part 2.1055(a)(1)(b)
Test Method:	ANSI/TIA-6-3-D 2010
Limit:	±2.5 ppm
Test setup:	SS BUT EUT Divider Temperature & Humidity Chamber Power Source
Test procedure:	 The equipment under test was connected to an external DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (the worst channel):

Refe	erence Frequency: G	SM850 Middle	channel=190 chai	nnel=836.6MHz	
Power supplied	Temperature (°C)	Frequency error		Limit (none)	Daguit
(Vdc)		Hz	ppm	Limit (ppm)	Result
	-30	176	0.210375		Pass
	-20	157	0.187664		
	-10	138	0.164953]	
	0	127	0.151805		
3.80	10	116	0.138656	±2.5	
	20	144	0.172125		
	30	141	0.168539		
	40	130	0.155391		
	50	119	0.142242		
Refe	erence Frequency: Po	CS1900 Middl	e channel=661 cha	nnel=1880MHz	
Power supplied	Temperature (°C)	Freq	uency error	Limit (ppm)	Result
(Vdc)	remperature (c)	Hz	ppm	Limit (ppin)	
	-30	181	0.096277		
	-20	158	0.084043		Pass
	-10	144	0.076596		
	0	132	0.070213		
3.80	10	128	0.068085	±2.5	
	20	119	0.063298		
	30	110	0.058511		
	40	141	0.075000		
	50	149	0.079255	1	





Power supplied	quency: WCDMA BAI	Frequency error			
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	168	0.200813		Pass
	-20	141	0.168539		
	-10	134	0.160172		
	0	121	0.144633		
3.80	10	107	0.127899	±2.5	
	20	159	0.190055		
	30	161	0.192446		
	40	137	0.163758		
	50	144	0.172125		
Reference Fre	quency: WCDMA BA	ND II 12.2k RI	MC Middle channe	l=9400 channel=1	880MHz
Power supplied	Temperature (°C)	Frequency error		Limit (ppm)	Result
(Vdc)	remperature (c)	Hz	ppm	Еши (ррш)	Nesuit
	-30	188	0.10000		
	-20	150	0.07979		
	-20 -10	150 141	0.07979 0.07500		
3.80	-10	141	0.07500	±2.5	Pass
3.80	-10 0	141 164	0.07500 0.08723	±2.5	Pass
3.80	-10 0 10	141 164 143	0.07500 0.08723 0.07606	±2.5	Pass
3.80	-10 0 10 20	141 164 143 125	0.07500 0.08723 0.07606 0.06649	±2.5	Pass



6.8 Frequency stability V.S. Voltage measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235 FCC Part 2.1055(d)(2)
Test Method:	ANSI/TIA-603-D 2010
Limit:	±2.5ppm
Test setup:	SS EUT Divider Temperature & Humidity Chamber
Test procedure:	 Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. Reduce the input voltage to specify extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (the worst channel):

Reference Frequency: GSM850 Middle channel=190 channel=836.6MHz							
Temperature (°C)	Power supplied	Freque	ncy error	Limit (ppm)	Result		
remperature (C)	(Vdc)	Hz	ppm				
	4.35	87	0.103992				
25	3.80	80	0.095625	±2.5	Pass		
	3.55	70	0.083672				
Refe	Reference Frequency: PCS1900 Middle channel=661 channel=1880MHz						
Temperature (°C)	Power supplied	Frequency error		Limit (nnm)	Result		
remperature (C)	(Vdc)	Hz	ppm	Limit (ppm)	Result		
	4.35	92	0.048936				
25	3.80	76	0.040426	±2.5	Pass		
	3.55	82	0.043617	1			
Note: Only the worst case shown in the report.							





Reference Frequency: UMTS 850 12.2k RMC Middle channel=4183 channel=836.6MHz							
Temperature (℃)	Power supplied (Vdc)	Frequency error		Limit (nam)	Desuit		
		Hz	ppm	Limit (ppm)	Result		
	4.35	83	0.099211				
25	3.80	89	0.106383	±2.5	Pass		
	3.55	62	0.074109				
Reference	Reference Frequency: UMTS 1900 12.2k RMC Middle channel=9400 channel=1880MHz						
Tomporoture (°C)	Power supplied	Frequency error		Limit (nnm)	Result		
Temperature (℃)	(Vdc)	Hz	ppm	Limit (ppm)	Resuit		
	4.35	76	0.04043				
25	3.80	79	0.04202	±2.5	Pass		
	3.55	67	0.03564		1		
Note: Only the worst case shown in the report.							